

# MP7636A



15 V CMOS Microprocessor Compatible  
Double-Buffered, Multiplying 16-Bit  
Digital-to-Analog Converter

## FEATURES

- Four Quadrant Multiplication
- 16-Bit Monotonicity
- Lower Data Bus Feedthrough @  $\overline{CS} = 1$
- Low Feedthrough Error
- Low Power Consumption
- TTL/5 V CMOS Compatible
- Double Buffered
- Decoded DAC Approach
- Latch-Up Free

## BENEFITS

- High Accuracy Performance at Low Cost
- Easy Interface with 8-Bit Microprocessors
- Simple Upgrade of MP1230A Family to High Accuracy (Pin Compatible)
- Reduced Board Space
- 16-Bit Bus Version: MP7626

## GENERAL DESCRIPTION

The MP7636A is manufactured using advanced thin film resistors on a double metal CMOS process. The MP7636A incorporates a unique bit decoding technique yielding lower glitch, higher speed and excellent accuracy over temperature and time. 16-bit differential non-linearity is achieved with minimal laser trim.

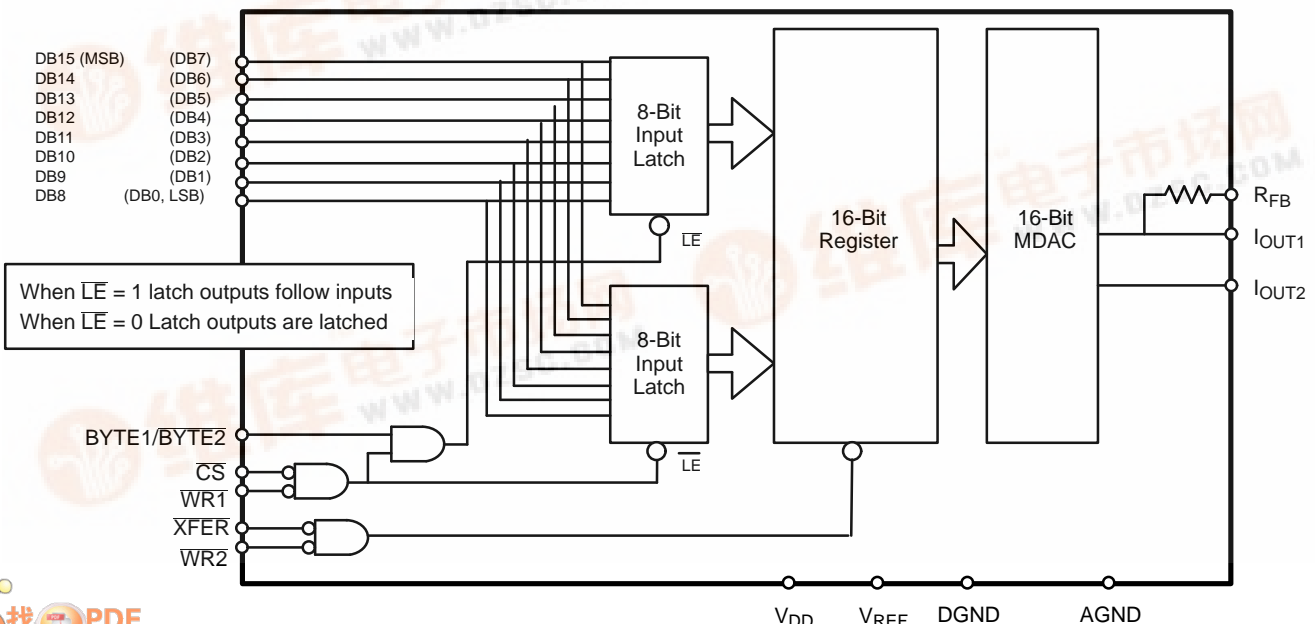
The MP7636A is packaged in a 20-pin 300 mil wide DIP and is a direct 16-bit replacement for the 12-bit DAC1230 series. Full

pin-for-pin compatibility allows existing systems to be upgraded to 16 bits without hardware modification.

The MP7636A provides 16-bit data loading through 8 input data lines for direct interface to 8-bit data buses. All data loading and data transfer operations are identical to the WRITE cycle of a static RAM.

The MP7636A uses a unique circuit which significantly reduces transients in the supplies during DATA bus transitions at  $\overline{CS} = 1$ .

## SIMPLIFIED BLOCK DIAGRAM



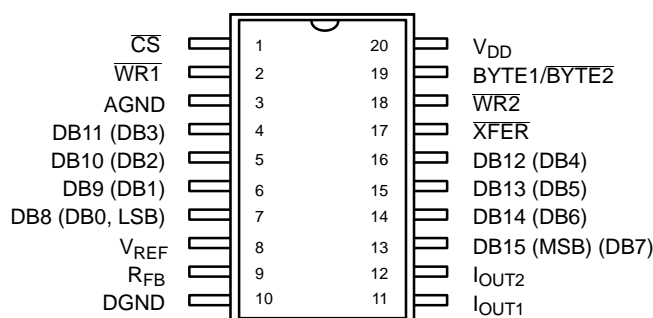
## ORDERING INFORMATION

Package Type	Temperature Range	Part No.	INL (LSB)	DNL (LSB)	Gain Error (% FSR)
SOIC	-40 to +85°C	MP7636AJS	±4	±4	0.1
SOIC	-40 to +85°C	MP7636AKS	±2	±2	0.1

\*Contact factory for non-compliant military processing

## PIN CONFIGURATION

See Packaging Section for Package Dimensions



20 Pin SOIC (Jedec, 0.300")  
S20

## PIN OUT DEFINITIONS

PIN NO.	NAME	DESCRIPTION
1	$\overline{CS}$	Chip Select (Active Low)
2	$\overline{WR1}$	Write1 (Active Low)
3	AGND	Analog Ground
4	DB11 (DB3)	Data Input Bit 11 (MSB) Data Input Bit 3
5	DB10 (DB2)	Data Input Bit 10 Data Input Bit 2
6	DB9 (DB1)	Data Input Bit 9 Data Input Bit 1
7	DB8 (DB0)	Data Input Bit 8 Data Input Bit 0 (LSB)
8	$V_{REF}$	Reference Input Voltage
9	$R_{FB}$	Internal Feedback Resistor
10	DGND	Digital Ground
11	$I_{OUT1}$	Current Output 1

PIN NO.	NAME	DESCRIPTION
12	$I_{OUT2}$	Current Output 2
13	DB15 (MSB) (DB7)	Data Input Bit 15 (Most Significant Bit) Data Input Bit 7
14	DB14 (DB6)	Data Input Bit 14 Data Input Bit 6
15	DB13 (DB5)	Data Input Bit 13 Data Input Bit 5
16	DB12 (DB4)	Data Input Bit 12 Data Input Bit 4
17	XFER	Transfer Control Signal (Active Low)
18	$\overline{WR2}$	Write 2 (Active Low)
19	BYTE1/ $\overline{BYTE2}$	Byte Sequence Control
20	$V_{DD}$	Power Supply

## ELECTRICAL CHARACTERISTICS

( $V_{DD} = +15\text{ V}$ ,  $V_{REF} = +10\text{ V}$  unless otherwise noted)

Parameter	Symbol	25°C			Tmin to Tmax		Units	Test Conditions/Comments	
		Min	Typ	Max	Min	Max			
<b>STATIC PERFORMANCE<sup>1</sup></b>									
Resolution (All Grades)	N	16			16		Bits	FSR = Full Scale Range	
Integral Non-Linearity (Relative Accuracy)	INL						LSB		
J, S				±4			±4	Best Fit Straight Line Spec. (Max INL – Min INL) / 2	
K, L, T				±2			±2		
Differential Non-Linearity	DNL						LSB	All grades guaranteed monotonic over full operating temperature range.	
J, S				±4			±4		
K, T				±2			±2		
L				±1			±2		
Gain Error	GE			±0.1			±0.1	% FSR	Using Internal $R_{FB}$
Gain Temperature Coefficient <sup>2</sup>	$TC_{GE}$						±2	ppm/°C	$\Delta\text{Gain}/\Delta\text{Temperature}$
Power Supply Rejection Ratio	PSRR			±50			±50	ppm/%	$ \Delta\text{Gain}/\Delta V_{DD} $ $\Delta V_{DD} = \pm 5\%$
Output Leakage Current	$I_{OUT}$			±10			±200	nA	$I_{OUT1}$ only
<b>DYNAMIC PERFORMANCE<sup>2</sup></b>									
Current Settling Time	$t_S$		2					μs	To 1/2 LSB $R_L = 100\Omega$ , $C_{EXT} = 13\text{pF}$
AC Feedthrough at $I_{OUT1}$	$F_T$		2					mV p-p	$V_{REF} = 20\text{ V p-p}$ Sine wave @ 10kHz
<b>REFERENCE INPUT</b>									
Input Resistance	$R_{IN}$	2.5		7.5	2.5	7.5		kΩ	
<b>LOGIC INPUTS<sup>3</sup></b>									
Input High Voltage	$V_{INH}$	3.0	2.4		3.0			V	
Input Low Voltage	$V_{INL}$			0.8			0.8	V	
Input Current	$I_{LKG}$			±1			±1	μA	
Input Capacitance									
Data	$C_{IN}$		5					pF	
Control	$C_{IN}$		5					pF	
<b>ANALOG OUTPUTS<sup>2</sup></b>									
Output Capacitance									
	$C_{OUT1}$			280				pF	DAC all 1's
	$C_{OUT1}$			120				pF	DAC all 0's
	$C_{OUT2}$			100				pF	DAC all 1's
	$C_{OUT2}$			240				pF	DAC all 0's

## ELECTRICAL CHARACTERISTICS (CONT'D)

Parameter	Symbol	25°C			Tmin to Tmax		Units	Test Conditions/Comments
		Min	Typ	Max	Min	Max		
<b>POWER SUPPLY<sup>5</sup></b>								
Functional Voltage Range <sup>2</sup>	V <sub>DD</sub>	4.5		16.5	5.0	16.5	V	All digital inputs 0 V or V <sub>DD</sub>
Supply Current	I <sub>DD</sub>			1		1	mA	
<b>SWITCHING CHARACTERISTICS<sup>2, 4</sup></b>								
$\overline{CS}$ to $\overline{WR}$ Set-Up Time	t <sub>CS</sub>	150					ns	
$\overline{CS}$ to $\overline{WR}$ Hold Time	t <sub>CH</sub>	10					ns	
Data Valid to $\overline{WR}$ Set-Up Time	t <sub>DS</sub>	70					ns	
Data Valid to $\overline{WR}$ Hold Time	t <sub>DH</sub>	70					ns	
$\overline{WR}$ , $\overline{XFER}$ Pulse Width	t <sub>W</sub>	150					ns	

### NOTES:

- (1) Full Scale Range (FSR) is 10V for unipolar mode.
- (2) Guaranteed but not production tested.
- (3) Digital input levels should not go below ground or exceed the positive supply voltage, otherwise damage may occur.
- (4) See timing diagram.
- (5) Specified values guarantee functionality. Refer to other parameters for accuracy.

Specifications are subject to change without notice

## ABSOLUTE MAXIMUM RATINGS (TA = +25°C unless otherwise noted)<sup>1, 2, 3</sup>

Voltage at Any Digital Input . . . . . GND -0.5 to V <sub>DD</sub> +0.5 V	AGND to DGND . . . . . ±1 V (Functionality Guaranteed ±0.5 V)
Voltage at V <sub>REF</sub> Input . . . . . ±25 V	Storage Temperature Range . . . . . -65°C to 150°C
DC Voltage Applied to I <sub>OUT1</sub> or I <sub>OUT2</sub> GND -0.5 V to +17 V	Package Power Dissipation Rating to 75°C
Supply Voltage (V <sub>DD</sub> ) . . . . . +17 V <sub>DC</sub>	SOIC . . . . . 900mW
	Derates above 75°C . . . . . 12mW/°C

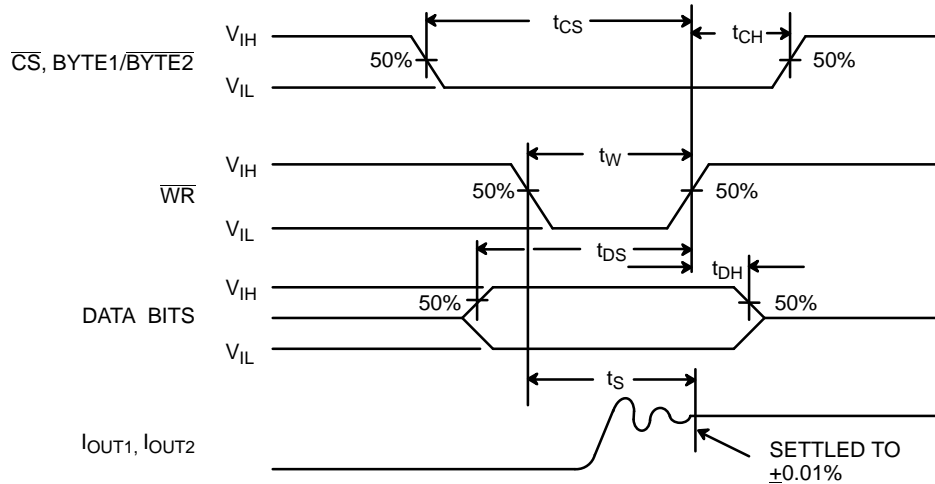
### NOTES:

- <sup>1</sup> Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation at or above this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.
- <sup>2</sup> Any input pin which can see a value outside the absolute maximum ratings should be protected by Schottky diode clamps (HP5082-2835) from input pin to the supplies. *All inputs have protection diodes* which will protect the device from short transients outside the supplies of less than 100mA for less than 100µs.
- <sup>3</sup> GND refers to AGND and DGND.

## APPLICATION NOTES

Refer to Section 8 for Applications Information

## TIMING DIAGRAM

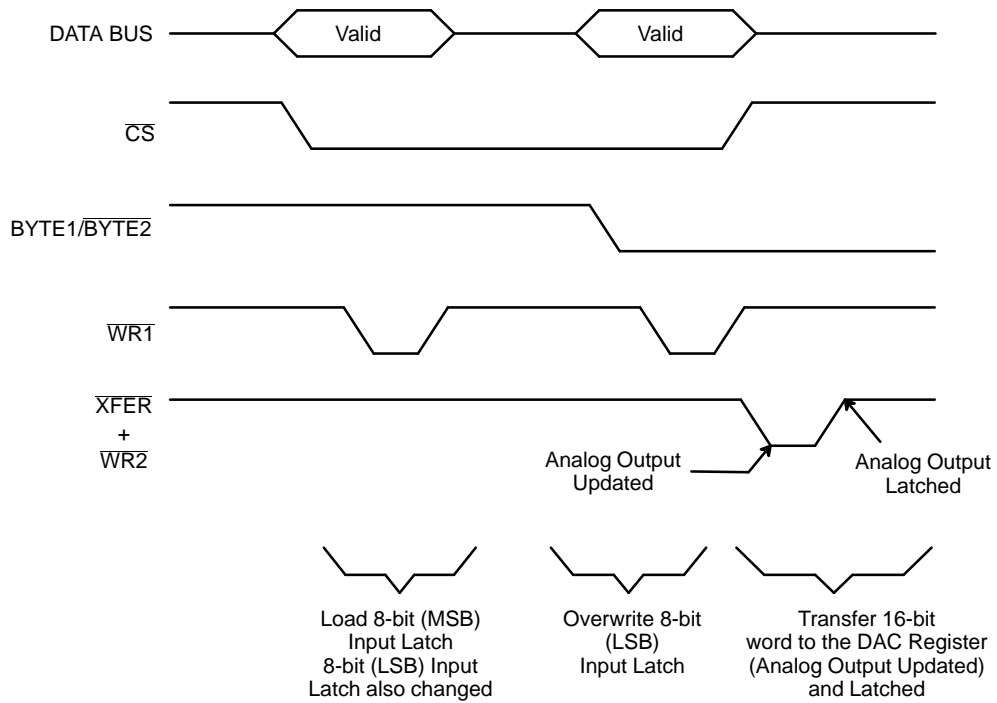


### DEFINITION OF CONTROL SIGNALS:

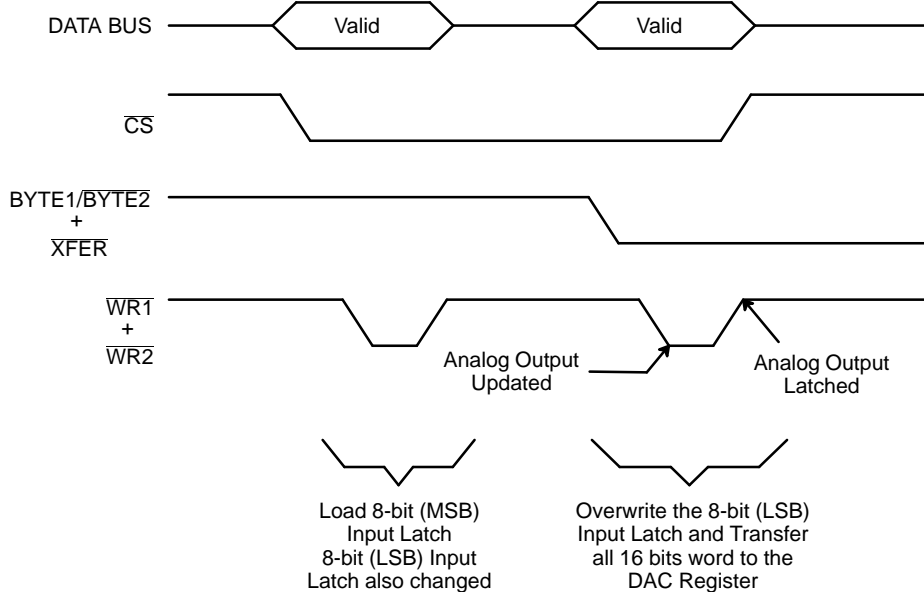
- $\overline{CS}$ : Chip Select (Active low).  
It will enable  $\overline{WR1}$ .
- $\overline{WR1}$ : Write 1 (Active low)  
The  $\overline{WR1}$  is used to load the digital data bits (DB) into the input latch.
- $\overline{BYTE1/BYTE2}$ : Byte sequence control.  
The  $\overline{BYTE1/BYTE2}$  control pin is used to select MSB and LSB both input latches.
- $\overline{WR2}$ : Write 2 (Active low).  
It will enable  $\overline{XFER}$ .
- $\overline{XFER}$ : Transfer control signal (Active low).  
This signal, in combination with  $\overline{WR2}$ , causes the 16-bit data which is available in the input latches to transfer to the DAC register.
- DB0 to DB15: Digital Inputs.  
DB0 is the least significant digital input (LSB) and DB15 is the most significant digital input (MSB).
- $I_{OUT1}$ : DAC Current Output 1 Bus.  
 $I_{OUT1}$  is a maximum for a digital code of all 1's in the DAC register, and is zero for all 0's in the DAC register.

- $I_{OUT2}$ : DAC Current Output 2 Bus.  
 $I_{OUT2}$  is a complement of  $I_{OUT1}$ . The ladder termination has been tied to  $I_{OUT2}$  internally.
- $R_{FB}$ : Feedback Resistor.  
This internal feedback resistor should always be used (not an external resistor) since it matches the resistors in the DAC and tracks these resistor over temperature.
- $V_{REF}$ : Reference Voltage Input.  
This input connects an external precision voltage source to the internal DAC. The  $V_{REF}$  can be selected over the range of +25V to -25V or the analog signal for a 4-quadrant multiplying mode application.
- $V_{DD}$ : Power Supply Voltage.  
This is the power supply pin for the part. The  $V_{DD}$  can be from +5 V DC to +15 V DC, however optimum voltage is +15 V DC.
- AGND: Analog Ground.  
Back gate of the DAC N-channel current steering switches.
- DGND: Digital Ground .

The timing diagrams for updating the DAC register are shown in *Figures 1 and 2*.

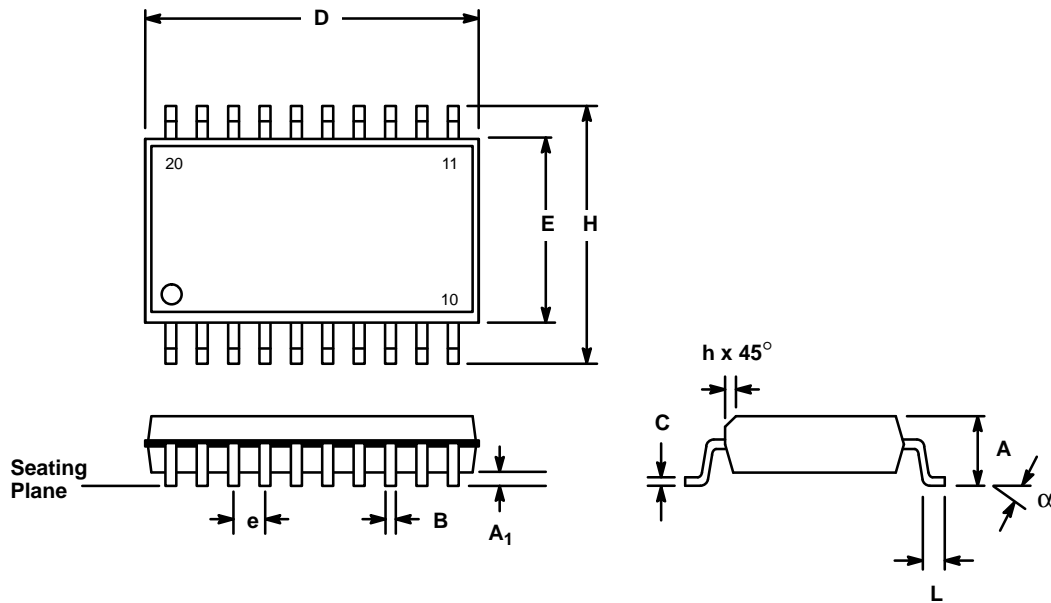


**Figure 1. Typical Interface with an 8-bit Data Bus**



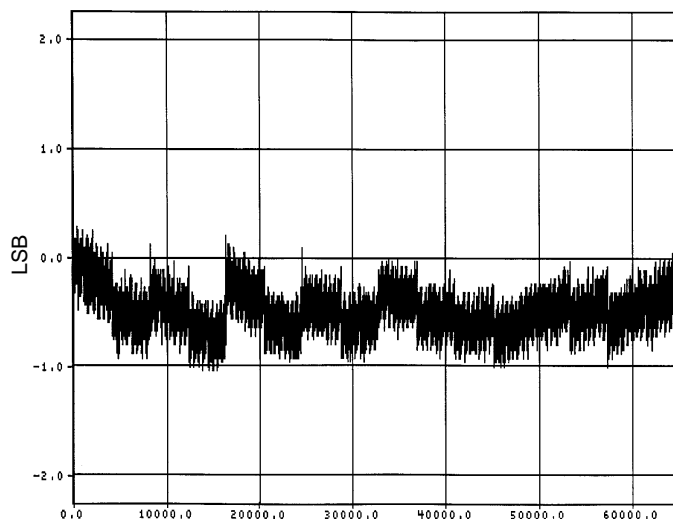
**Figure 2. Automatic Transfer**

**20 LEAD SMALL OUTLINE  
(300 MIL JEDEC SOIC)  
S20**



SYMBOL	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.097	0.104	2.464	2.642
A <sub>1</sub>	0.0050	0.0115	0.127	0.292
B	0.014	0.019	0.356	0.483
C	0.0091	0.0125	0.231	0.318
D	0.500	0.510	12.70	12.95
E	0.292	0.299	7.42	7.59
e	0.050 BSC		1.27 BSC	
H	0.400	0.410	10.16	10.41
h	0.010	0.016	0.254	0.406
L	0.016	0.035	0.406	0.889
α	0°	8°	0°	8°

## PERFORMANCE CHARACTERISTICS



**Graph 1. Relative Accuracy vs. Digital Code**

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